MSKSEMI















ESD

TVS

TSS

MOV

GDT

PLED

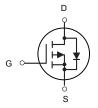
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Semiconductor







P-Channel MOSFET

Description

The SI2333CDS-T1-MS uses advanced trench technology to provide excellent R_{DS(ON)}, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

 $V_{DS} = -18V, I_{D} = -7A$

 $R_{DS(ON)}$ < 22m Ω @ V_{GS} =4.5V

Application

High power and current handing capability
Lead free product is acquired
Surface mount package
PWM applications
Load switch
Power management

Absolute Maximum Ratings (T_A=25 ℃ unless otherwise noted)

Symbol	Parameter	Limit	Unit	
V _{DS}	Drain-Source Voltage	-18	V	
V _G s	Gate-Source Voltage	±12	V	
I _D	Drain Current-Continuous	-7	А	
Ідм	Drain Current-Pulsed (Note 1)	-18.8	А	
P _D	Maximum Power Dissipation	1	W	
Тл,Твтв	T _J ,T _{STG} Operating Junction and Storage Temperature Range		$^{\circ}\mathbb{C}$	
Reja	ReJA Thermal Resistance,Junction-to-Ambient (Note 2)		°C/W	

Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-18			V
△BV _{DSS} /△T _J	BVDSS Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.01		V/°C
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =-4.5V , I _D =-6.5A		18	22	mΩ
		V _{GS} =-2.5V , I _D =-5A		25	39	
		V _{GS} =-1.8V , I _D =-1.5A				
V _{GS(th)}	Gate Threshold Voltage	\/ -\/ - 250\	-0.6	-0.8	-1.4	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=-250uA$				mV/°C
I _{DSS}	Drain Source Leakage Current	V _{DS} =-20V , V _{GS} =0V , T _J =25°C			-1	uA
	Drain-Source Leakage Current	V _{DS} =-16V , V _{GS} =0V , T _J =55°C				uA
I _{GSS}	Gate-Source Leakage Current	V _{GS} =± 12V , V _{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-3A		10		S
Q_g	Total Gate Charge (-4.5V)	V _{DS} =-10V , V _{GS} =-4.5V , I _D =-6 A 5		10		
Q _{gs}	Gate-Source Charge			1.5		nC
Q_{gd}	Gate-Drain Charge			3		
T _{d(on)}	Turn-On Delay Time			30		
T _r	Rise Time	V_{DD} =-10V , V_{GS} =-4.5V , R_G =6.0 Ω		25		
$T_{d(off)}$	Turn-Off Delay Time			70		ns
T _f	Fall Time			50		
C _{iss}	Input Capacitance	V _{DS} =-10V , V _{GS} =0V , f=1MHz		1210		
Coss	Output Capacitance			310		pF
C _{rss}	Reverse Transfer Capacitance			290		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,4}	V =V =0V Force Current			-7.0	Α
I _{SM}	Pulsed Source Current ^{2,4}	V _G =V _D =0V , Force Current			-18.8	Α
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1	V
t _{rr}	Reverse Recovery Time			52		nS
Q _{rr}	Reverse Recovery Charge	IF=-4A , dI/dt=100A/µs , T _J =25°C		28		nC

Note

- 1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3. The power dissipation is limited by 150°C junction temperature
- 4. The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.

Typical Characteristics

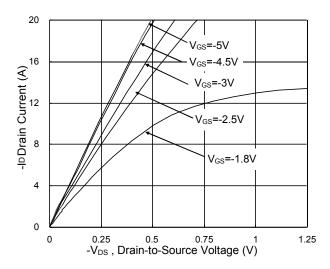


Fig.1 Typical Output Characteristics

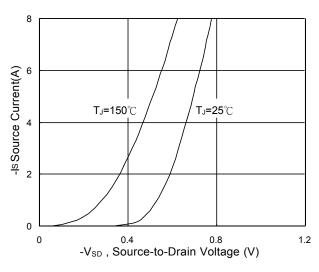


Fig.3 Forward Characteristics Of Reverse

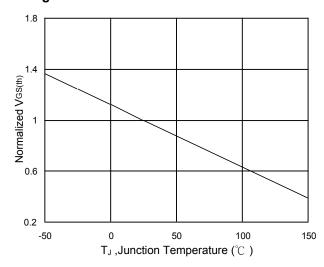


Fig.5 Normalized $V_{\text{GS(th)}}$ vs. T_J

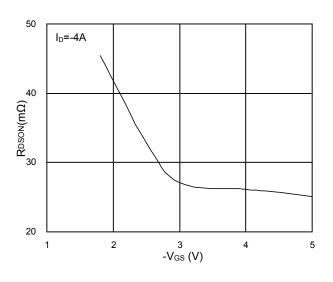


Fig.2 On-Resistance vs. Gate-Source

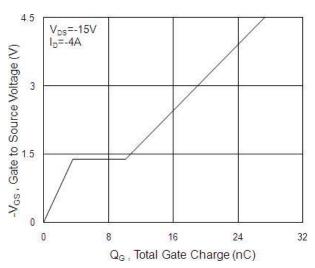


Fig.4 Gate-Charge Characteristics

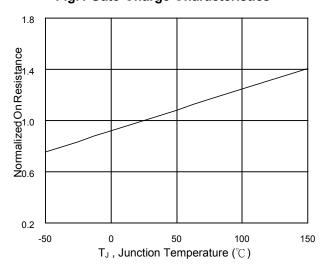
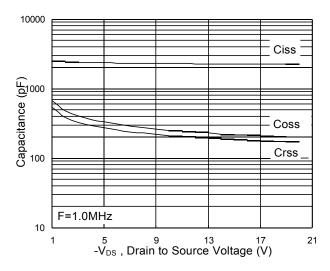


Fig.6 Normalized R_{DSON} vs. T_J



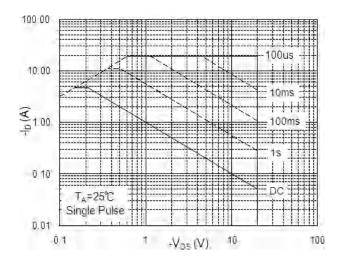


Fig.7 Capacitance

Fig.8 Safe Operating Area

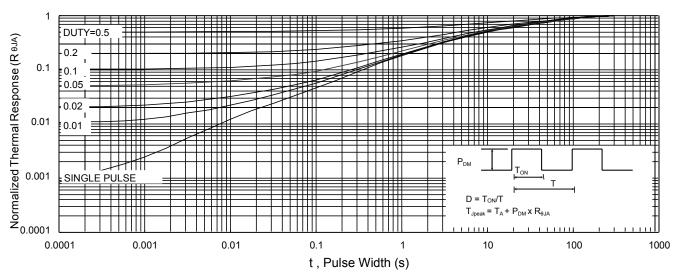


Fig.9 Normalized Maximum Transient Thermal Impedance

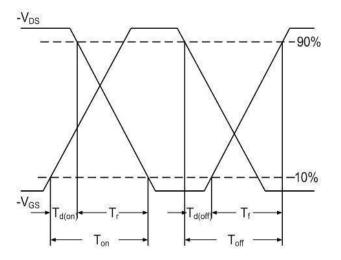


Fig.10 Switching Time Waveform

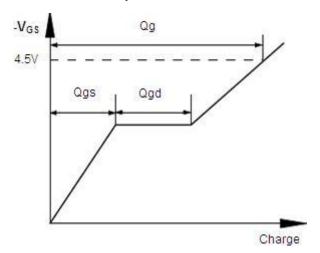
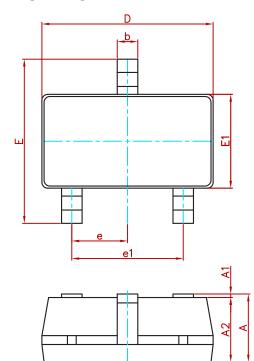
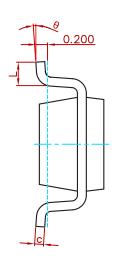
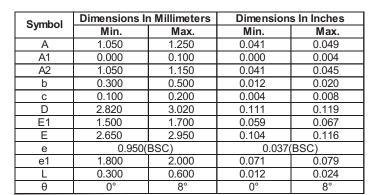


Fig.11 Gate Charge Waveform

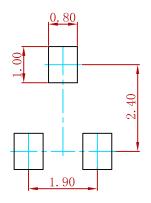
PACKAGE MECHANICAL DATA







Suggested Pad Layout



Note:

- 1. Controlling dimension: in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
SI2333CDS-T1-MS	SOT-23-3L	3000



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